

Photograph No.1 Setup for carrier and spurious emission field strength measurements in the anechoic chamber below 30 MHz





Photograph No.2 Setup for spurious emission field strength measurements in the anechoic chamber in 30 – 1000 MHz range



Photograph No.3 Setup for spurious emission field strength measurements in the anechoic chamber above 1 GHz

Photograph No.4 Setup for spurious emission field strength measurements in the anechoic chamber, EUT cabling



Photograph No.5 Setup for conducted emission measurements on the AC power lines



Photograph No.6 Setup for conducted emission measurements on the AC power lines